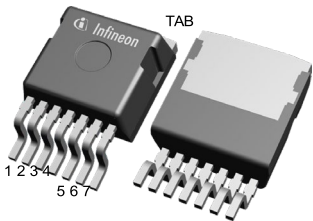


最终数据手册

英飞凌CoolSiC™ 1200 V SiC 沟槽 MOSFET：碳化硅MOSFET

特性

- $T_{vj} = -40 \dots 200^{\circ}\text{C}$  时  $V_{DSS} = 1200\text{ V}$
- $T_C = 25^{\circ}\text{C}$  时  $I_{DC} = 30\text{ A}$
- $R_{DS(on)} = 80\text{ m}\Omega$  ( $V_{GS} = 20\text{ V}$ 、 $T_{vj} = 25^{\circ}\text{C}$  时)
- 新的性能优化芯片技术 (Gen1p)，改善了  $R_{DS(on)} \cdot A$
- 业界领先的开关能量特性，可降低开关损耗并减少冷却需求
- 最低的器件电容值，可实现更高的开关速度和更高的功率密度
- 低  $C_{rss}/C_{iss}$  电容比值和高  $V_{GS(th)}$  的组合，可避免寄生导通并实现单极性栅极驱动
- 降低了总栅极电荷  $Q_G$ ，可降低驱动功率和损耗
- 提高了建议开启电压 ( $V_{GS(on)} = 20\text{ V}$ ) 以降低  $R_{DS(on)}$
- .XT 芯片粘接技术，实现业界领先的热性能
- 低封装杂散电感，可实现更快、更干净的开关动作
- 带有开尔文 (Kelvin) 源极引脚，实现更好的栅极控制并降低开关损耗
- 爬电距离为 5.8 毫米 (材料组 II)，适用于 800 V 应用
- SMT 封装，便于自动化装配并降低系统成本



- Halogen-free
- Green
- Lead-free
- RoHS

潜在的应用

- 车载充电器
- 直流/直流转换器
- 辅助驱动

产品验证

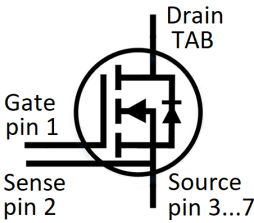
- 适合汽车应用。根据 AEC-Q100/101 进行产品验证

描述

引脚定义：

- Pin 1 - 栅极
- Pin 2 - 开尔文检测
- Pin 3...7 - 源极
- Tab - 漏极

注意：源极引脚和检测引脚不可互换，互换可能会导致故障



| Type           | Package        | Marking |
|----------------|----------------|---------|
| AIMBG120R080M1 | PG-TO263-7-U01 | AS80MM1 |

本数据手册的原文使用英文撰写。为方便起见，英飞凌提供了译文；由于翻译过程中可能使用了自动化工具，英飞凌不保证译文的准确性。为确认准确性，请务必访问 [infineon.com](http://infineon.com) 参考最新的英文版本（控制文档）。



目录

|   |                       |    |
|---|-----------------------|----|
|   | 说明                    |    |
|   | 特征 .....              | 1  |
|   | 潜在的应用                 |    |
|   | 产品验证 .....            | 1  |
|   | 目录                    |    |
| 1 | 封装                    |    |
| 2 | MOSFET .....          | 3  |
| 3 | 体二极管 ( MOSFET ) ..... | 5  |
| 4 | 特征图.....              | 7  |
| 5 | 封装外形 .....            | 13 |
| 6 | 测试条件.....             | 14 |
|   | 修订记录                  |    |
|   | 免责声明.....             | 16 |

1 封装

1 封装

表1 特征值

| Parameter                                                         | Symbol               | Note or test condition | Values |      |      | Unit |
|-------------------------------------------------------------------|----------------------|------------------------|--------|------|------|------|
|                                                                   |                      |                        | Min.   | Typ. | Max. |      |
| Storage temperature                                               | $T_{\text{stg}}$     |                        | -55    |      | 150  | °C   |
| Soldering temperature                                             | $T_{\text{sold}}$    |                        |        |      | 260  | °C   |
| MOSFET/body diode thermal resistance, junction-case <sup>1)</sup> | $R_{\text{th(j-c)}}$ |                        |        | 0.68 | 0.89 | K/W  |

1) 无需经过生产测试 - 经过设计/特性验证

2 MOSFET

表2 最大额定值

| Parameter                                                                                                | Symbol           | Note or test condition                                                            |                                 | Values   | Unit |
|----------------------------------------------------------------------------------------------------------|------------------|-----------------------------------------------------------------------------------|---------------------------------|----------|------|
| Drain-source voltage <sup>1)</sup>                                                                       | $V_{\text{DSS}}$ | $T_{\text{vj}} = -55 \dots 175 \text{ °C}$                                        |                                 | 1200     | V    |
| Continuous DC drain current for $R_{\text{th(j-c,max)}}$ , limited by $T_{\text{vj(max)}}$ <sup>2)</sup> | $I_{\text{DDC}}$ | $V_{\text{GS}} = 20 \text{ V}$                                                    | $T_{\text{c}} = 25 \text{ °C}$  | 30.6     | A    |
|                                                                                                          |                  |                                                                                   | $T_{\text{c}} = 100 \text{ °C}$ | 21       |      |
| Peak drain current, $t_{\text{p}}$ limited by $T_{\text{vj(max)}}$ <sup>2)</sup>                         | $I_{\text{DM}}$  | $V_{\text{GS}} = 20 \text{ V}$                                                    |                                 | 78       | A    |
| Gate-source voltage, max. transient voltage <sup>3)</sup>                                                | $V_{\text{GS}}$  | $t_{\text{p}} \leq 0.5 \text{ }\mu\text{s}, D < 0.01$                             |                                 | -10...25 | V    |
| Gate-source voltage, max. static voltage <sup>3)</sup>                                                   | $V_{\text{GS}}$  |                                                                                   |                                 | -5...23  | V    |
| Avalanche energy, single pulse                                                                           | $E_{\text{AS}}$  | $I_{\text{D}} = 7.6 \text{ A}, V_{\text{DD}} = 50 \text{ V}, L = 4.76 \text{ mH}$ |                                 | 136      | mJ   |
| Power dissipation, limited by $T_{\text{vj(max)}}$ <sup>2)</sup>                                         | $P_{\text{tot}}$ |                                                                                   | $T_{\text{c}} = 25 \text{ °C}$  | 168      | W    |
|                                                                                                          |                  |                                                                                   | $T_{\text{c}} = 100 \text{ °C}$ | 84       |      |

1) 在  $T_{\text{vj}}=25\text{°C}$  下进行测试，并通过全温度范围内的设计/特性验证  
2) 无需经过生产测试 - 经过设计/特性验证  
3) **重要注释：** 正负栅极源电压的选择会影响器件的长期行为。为了确保器件在计划使用寿命内的正常运行，必须考虑应用说明AN2018-09中描述的设计指南。

表 3 建议值

| Parameter                         | Symbol               | Note or test condition | Values | Unit |
|-----------------------------------|----------------------|------------------------|--------|------|
| Recommended turn-on gate voltage  | $V_{\text{GS(on)}}$  |                        | 20     | V    |
| Recommended turn-off gate voltage | $V_{\text{GS(off)}}$ |                        | 0      | V    |

表4 特征值

| Parameter                                  | Symbol       | Note or test condition                                                                                                                                                             |                                                          | Values |      |      | Unit |
|--------------------------------------------|--------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------|--------|------|------|------|
|                                            |              |                                                                                                                                                                                    |                                                          | Min.   | Typ. | Max. |      |
| Drain-source on-state resistance           | $R_{DS(on)}$ | $I_D = 10\text{ A}$                                                                                                                                                                | $T_{vj} = 25\text{ °C}$ ,<br>$V_{GS(on)} = 20\text{ V}$  |        | 80   | 100  | mΩ   |
|                                            |              |                                                                                                                                                                                    | $T_{vj} = 100\text{ °C}$ ,<br>$V_{GS(on)} = 20\text{ V}$ |        | 112  |      |      |
|                                            |              |                                                                                                                                                                                    | $T_{vj} = 175\text{ °C}$ ,<br>$V_{GS(on)} = 20\text{ V}$ |        | 159  |      |      |
|                                            |              |                                                                                                                                                                                    | $T_{vj} = 25\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$  |        | 86   |      |      |
| Gate-source threshold voltage              | $V_{GS(th)}$ | $I_D = 3.3\text{ mA}$ , $V_{DS} = V_{GS}$<br>(tested after 1 ms pulse at $V_{GS} = 20\text{ V}$ )                                                                                  | $T_{vj} = 25\text{ °C}$                                  | 3.7    | 4.4  | 5.1  | V    |
|                                            |              |                                                                                                                                                                                    | $T_{vj} = 175\text{ °C}$                                 |        | 3.6  |      |      |
| Zero gate-voltage drain current            | $I_{DSS}$    | $V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                                                                                   | $T_{vj} = 25\text{ °C}$                                  |        | 0.3  | 10   | μA   |
|                                            |              |                                                                                                                                                                                    | $T_{vj} = 175\text{ °C}$                                 |        | 10   |      |      |
| Gate leakage current                       | $I_{GSS}$    | $V_{DS} = 0\text{ V}$                                                                                                                                                              | $V_{GS} = 25\text{ V}$                                   |        |      | 100  | nA   |
|                                            |              |                                                                                                                                                                                    | $V_{GS} = -10\text{ V}$                                  |        |      | -100 |      |
| Forward transconductance                   | $g_{fs}$     | $I_D = 10\text{ A}$ , $V_{DS} = 20\text{ V}$                                                                                                                                       |                                                          |        | 6.2  |      | S    |
| Short-circuit withstand time <sup>2)</sup> | $t_{SC}$     | $V_{DD} \leq 800\text{ V}$ ,<br>$V_{DS,peak} < 1200\text{ V}$ ,<br>$T_{vj(start)} = 25\text{ °C}$ ,<br>$R_{G,ext} = 2\text{ Ω}$                                                    | $V_{GS(on)} = 20\text{ V}$                               |        | 1.5  |      | μs   |
|                                            |              |                                                                                                                                                                                    | $V_{GS(on)} = 18\text{ V}$                               |        | 2    |      |      |
|                                            |              |                                                                                                                                                                                    | $V_{GS(on)} = 15\text{ V}$                               |        | 2.5  |      |      |
| Internal gate resistance                   | $R_{G,int}$  | $f = 1\text{ MHz}$ , $V_{AC} = 25\text{ mV}$                                                                                                                                       |                                                          |        | 3.8  |      | Ω    |
| Input capacitance                          | $C_{iss}$    | $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                                                   |                                                          |        | 671  |      | pF   |
| Output capacitance                         | $C_{oss}$    | $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                                                   |                                                          |        | 35   |      | pF   |
| Reverse transfer capacitance               | $C_{rss}$    | $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                                                   |                                                          |        | 2    |      | pF   |
| $C_{oss}$ stored energy                    | $E_{oss}$    | $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$                                                                                   |                                                          |        | 14   |      | μJ   |
| Total gate charge                          | $Q_G$        | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ , $V_{GS} = 0/20\text{ V}$ , turn-on pulse                                                                                           |                                                          |        | 24   |      | nC   |
| Plateau gate charge                        | $Q_{GS(pl)}$ | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ , $V_{GS} = 0/20\text{ V}$ , turn-on pulse                                                                                           |                                                          |        | 7    |      | nC   |
| Gate-to-drain charge                       | $Q_{GD}$     | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ , $V_{GS} = 0/20\text{ V}$ , turn-on pulse                                                                                           |                                                          |        | 4    |      | nC   |
| Turn-on delay time                         | $t_{d(on)}$  | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\text{ Ω}$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ °C}$                                  |        | 5.7  |      | ns   |
|                                            |              |                                                                                                                                                                                    | $T_{vj} = 175\text{ °C}$                                 |        | 5.7  |      |      |

(表格续下页.....)

3 Body diode (MOSFET)

表 4（续） 特征值

| Parameter                    | Symbol       | Note or test condition                                                                                                                                                            |                                      | Values |       |      | Unit             |
|------------------------------|--------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------|--------|-------|------|------------------|
|                              |              |                                                                                                                                                                                   |                                      | Min.   | Typ.  | Max. |                  |
| Rise time                    | $t_r$        | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\ \Omega$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 4.9   |      | ns               |
|                              |              |                                                                                                                                                                                   | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 5.7   |      |                  |
| Turn-off delay time          | $t_{d(off)}$ | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\ \Omega$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 11.6  |      | ns               |
|                              |              |                                                                                                                                                                                   | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 12.4  |      |                  |
| Fall time                    | $t_f$        | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\ \Omega$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 8     |      | ns               |
|                              |              |                                                                                                                                                                                   | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 9     |      |                  |
| Turn-on energy               | $E_{on}$     | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\ \Omega$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 58.3  |      | $\mu\text{J}$    |
|                              |              |                                                                                                                                                                                   | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 82.6  |      |                  |
| Turn-off energy              | $E_{off}$    | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\ \Omega$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 28.1  |      | $\mu\text{J}$    |
|                              |              |                                                                                                                                                                                   | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 28.5  |      |                  |
| Total switching energy       | $E_{tot}$    | $V_{DD} = 800\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 0/20\text{ V}$ , $R_{G,ext} = 2\ \Omega$ ,<br>$L_\sigma = 20\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  |        | 86.4  |      | $\mu\text{J}$    |
|                              |              |                                                                                                                                                                                   | $T_{vj} = 175\text{ }^\circ\text{C}$ |        | 111.1 |      |                  |
| Virtual junction temperature | $T_{vj}$     |                                                                                                                                                                                   |                                      | -55    |       | 175  | $^\circ\text{C}$ |

注释： 特征参数在 $T_{vj} = 25^\circ\text{C}$ 下测定，除非另有说明。

3 体二极管（MOSFET）

表5 最大额定值

| Parameter                                                                                       | Symbol    | Note or test condition                     |                                   | Values | Unit |
|-------------------------------------------------------------------------------------------------|-----------|--------------------------------------------|-----------------------------------|--------|------|
| Drain-source voltage <sup>1)</sup>                                                              | $V_{DSS}$ | $T_{vj} = -55...175\text{ }^\circ\text{C}$ |                                   | 1200   | V    |
| Continuous reverse drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ <sup>2)</sup> | $I_{SDC}$ | $V_{GS} = 0\text{ V}$                      | $T_c = 25\text{ }^\circ\text{C}$  | 22.7   | A    |
|                                                                                                 |           |                                            | $T_c = 100\text{ }^\circ\text{C}$ | 17     |      |
| Peak reverse drain current, $t_p$ limited by $T_{vj(max)}$ <sup>2)</sup>                        | $I_{SM}$  | $V_{GS} = 0\text{ V}$                      |                                   | 22.7   | A    |

1) 在  $T_{vj}=25^\circ\text{C}$  下进行测试，并通过全温度范围内的设计/特性验证  
2) 无需经过生产测试 - 经过设计/特性验证

表6 特征值

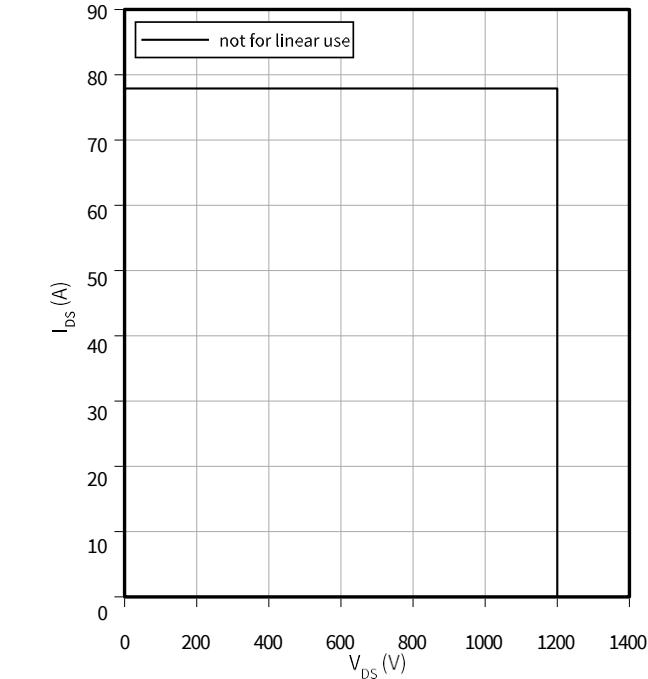
| Parameter                            | Symbol    | Note or test condition                                                                                                                                           |                                         | Values |      |      | Unit               |
|--------------------------------------|-----------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------|--------|------|------|--------------------|
|                                      |           |                                                                                                                                                                  |                                         | Min.   | Typ. | Max. |                    |
| Drain-source reverse voltage         | $V_{SD}$  | $I_{SD} = 10 \text{ A}$ , $V_{GS} = 0 \text{ V}$                                                                                                                 | $T_{vj} = 25 \text{ }^{\circ}\text{C}$  |        | 3.9  | 5    | V                  |
|                                      |           |                                                                                                                                                                  | $T_{vj} = 100 \text{ }^{\circ}\text{C}$ |        | 3.8  |      |                    |
|                                      |           |                                                                                                                                                                  | $T_{vj} = 175 \text{ }^{\circ}\text{C}$ |        | 3.7  |      |                    |
| MOSFET forward recovery charge       | $Q_{fr}$  | $V_{DD} = 800 \text{ V}$ ,<br>$I_{SD} = 10 \text{ A}$ , $V_{GS} = 0 \text{ V}$ ,<br>$-di_{SD}/dt = 1000 \text{ A}/\mu\text{s}$ , $Q_{fr}$<br>includes also $Q_c$ | $T_{vj} = 25 \text{ }^{\circ}\text{C}$  |        | 89   |      | nC                 |
|                                      |           |                                                                                                                                                                  | $T_{vj} = 175 \text{ }^{\circ}\text{C}$ |        | 175  |      |                    |
| MOSFET peak forward recovery current | $I_{frm}$ | $V_{DD} = 800 \text{ V}$ ,<br>$I_{SD} = 10 \text{ A}$ , $V_{GS} = 0 \text{ V}$ ,<br>$-di_{SD}/dt = 1000 \text{ A}/\mu\text{s}$ , $Q_{fr}$<br>includes also $Q_c$ | $T_{vj} = 25 \text{ }^{\circ}\text{C}$  |        | 5.1  |      | A                  |
|                                      |           |                                                                                                                                                                  | $T_{vj} = 175 \text{ }^{\circ}\text{C}$ |        | 7.7  |      |                    |
| Virtual junction temperature         | $T_{vj}$  |                                                                                                                                                                  |                                         | -55    |      | 175  | $^{\circ}\text{C}$ |

4 Characteristics diagrams

4 特性图

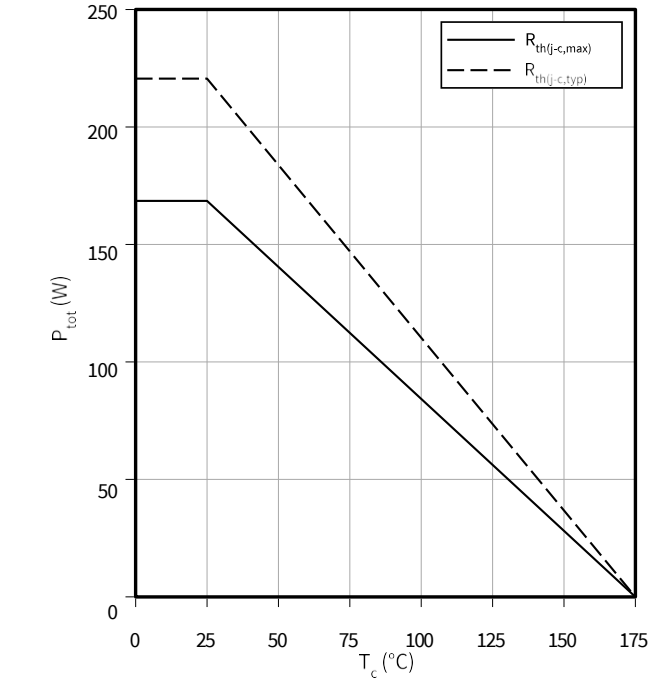
Reverse bias safe operating area (RBSOA)

$I_{DS} = f(V_{DS})$   
 $T_{vj} \leq 175\text{ °C}$ ,  $V_{GS} = 0/20\text{ V}$ ,  $T_c = 25\text{ °C}$



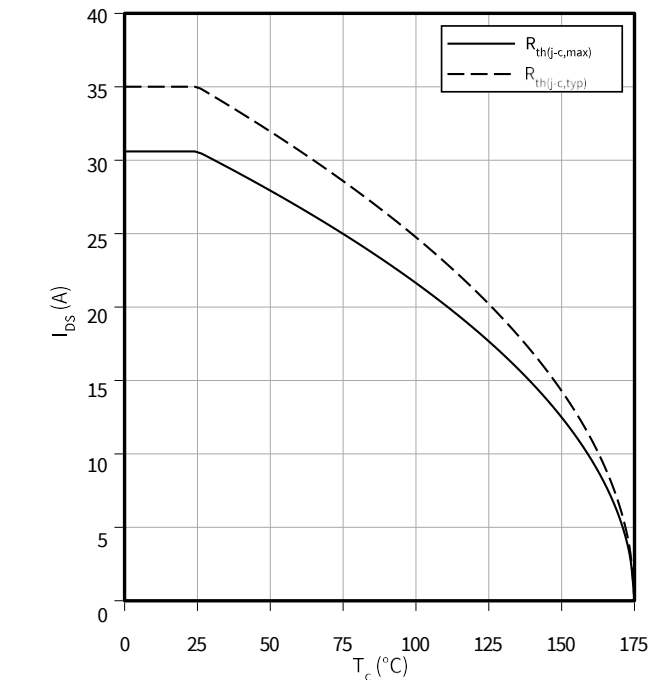
Power dissipation as a function of case temperature

$P_{tot} = f(T_c)$



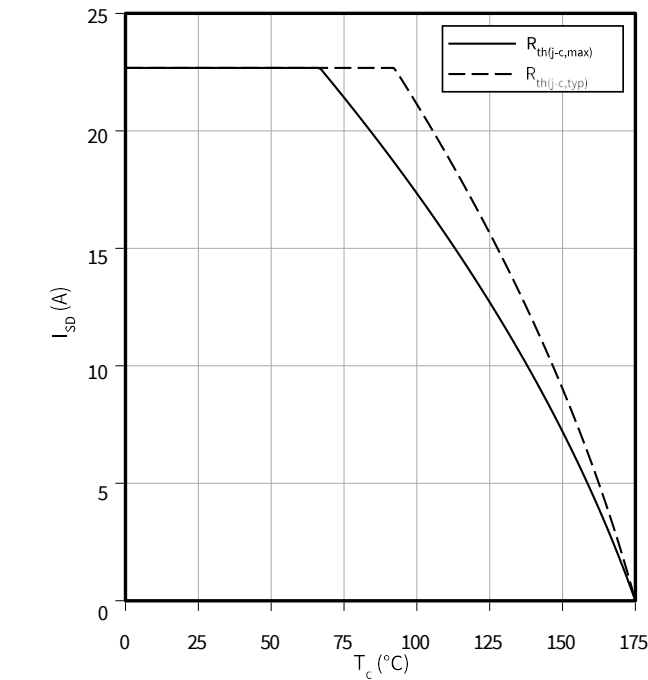
Maximum DC drain to source current as a function of case temperature

$I_{DS} = f(T_c)$



Maximum source to drain current as a function of case temperature

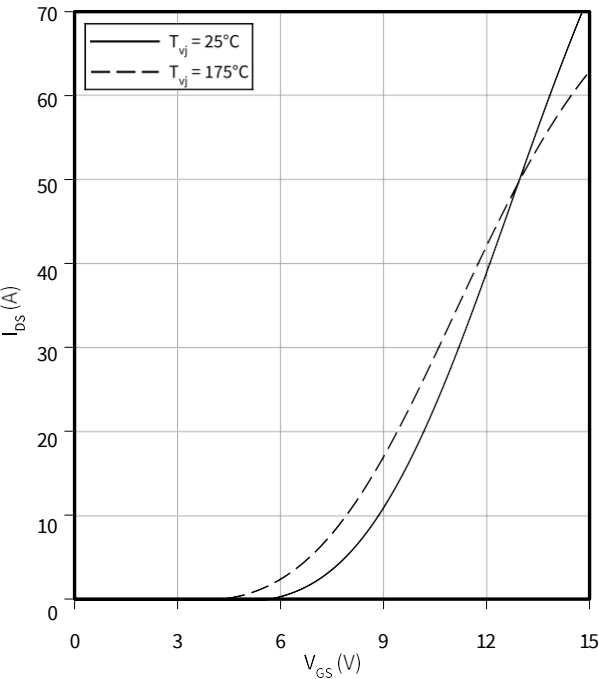
$I_{SD} = f(T_c)$   
 $V_{GS} = 0\text{ V}$



4 Characteristics diagrams

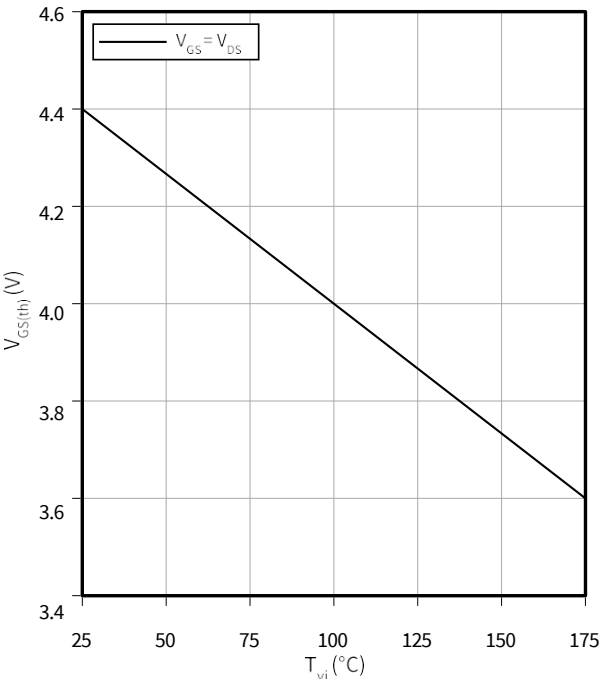
Typical transfer characteristic

$I_{DS} = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$ ,  $t_p = 20\text{ }\mu\text{s}$



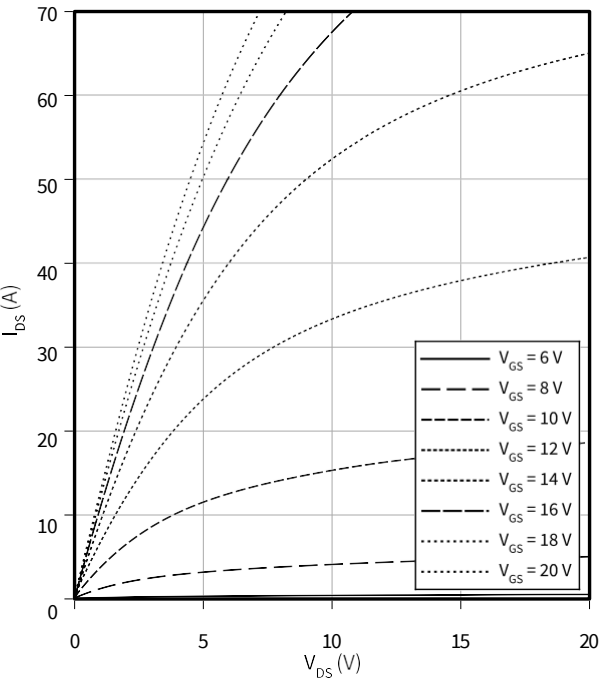
Typical gate-source threshold voltage as a function of junction temperature

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 3.3\text{ mA}$



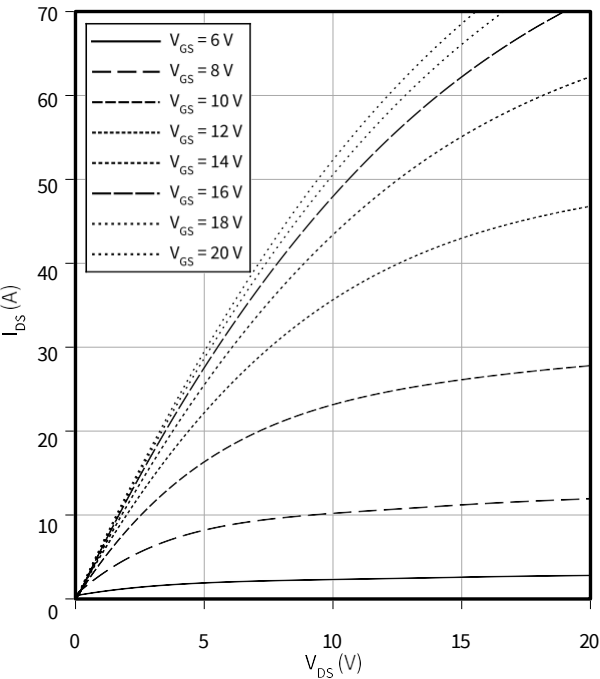
Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 25\text{ }^\circ\text{C}$ ,  $t_p = 20\text{ }\mu\text{s}$



Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 175\text{ }^\circ\text{C}$ ,  $t_p = 20\text{ }\mu\text{s}$

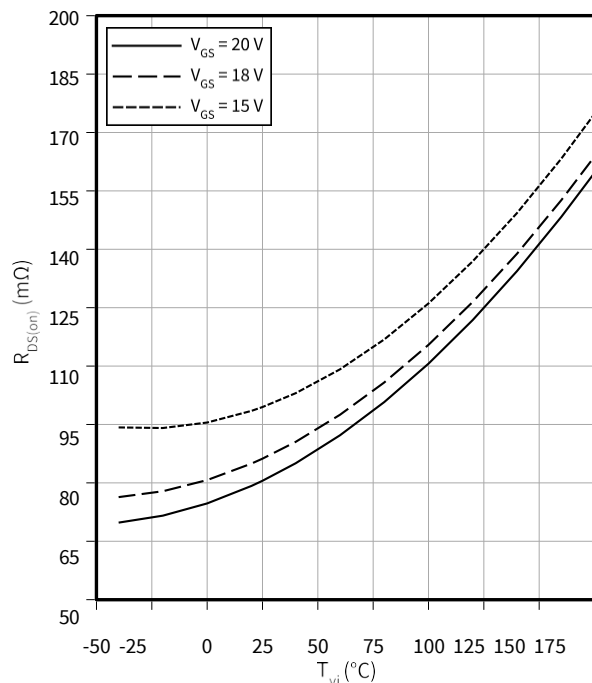


4 Characteristics diagrams

**Typical on-state resistance as a function of junction temperature**

$$R_{DS(on)} = f(T_{vj})$$

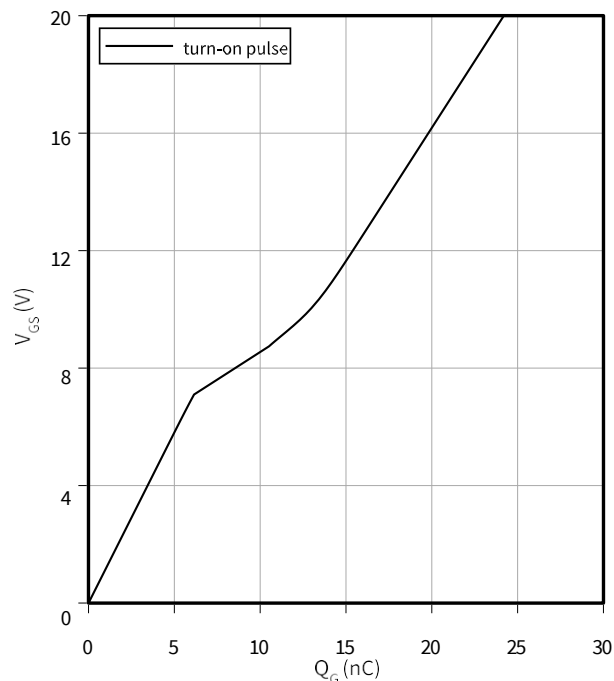
$I_D = 10 \text{ A}$



**Typical gate charge**

$$V_{GS} = f(Q_G)$$

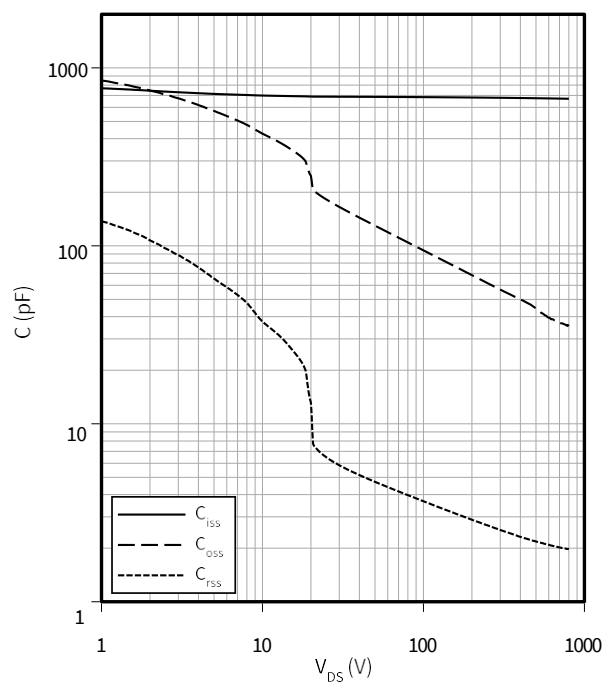
$I_D = 10 \text{ A}, V_{DS} = 800 \text{ V}$



**Typical capacitance as a function of drain-source voltage**

$$C = f(V_{DS})$$

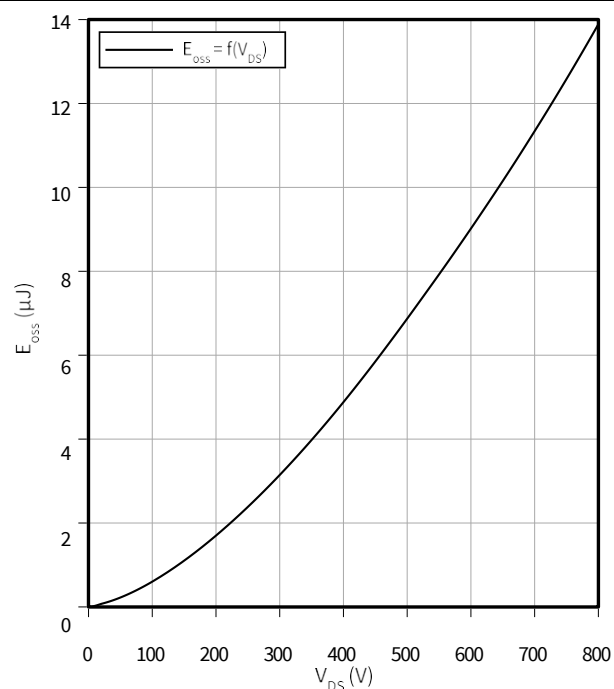
$f = 100 \text{ kHz}, V_{GS} = 0 \text{ V}$



**Typical  $C_{oss}$  stored energy**

$$E_{OSS} = f(V_{DS})$$

$f = 100 \text{ kHz}, V_{GS} = 0 \text{ V}$

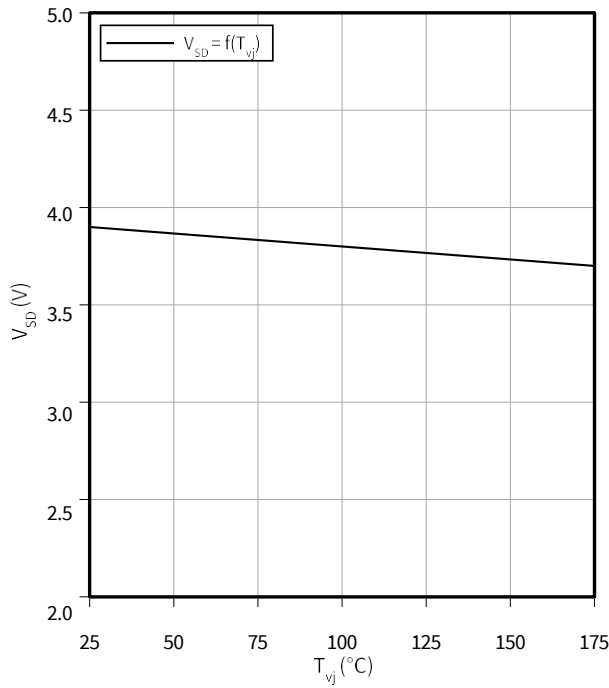


4 Characteristics diagrams

**Typical reverse drain voltage as function of junction temperature**

$$V_{SD} = f(T_{vj})$$

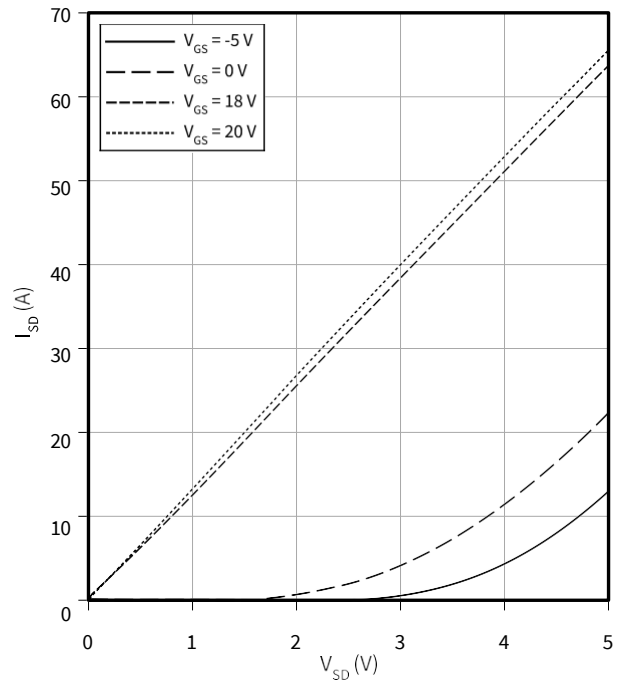
$$I_{SD} = 10 \text{ A}, V_{GS} = 0 \text{ V}$$



**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$$I_{SD} = f(V_{SD})$$

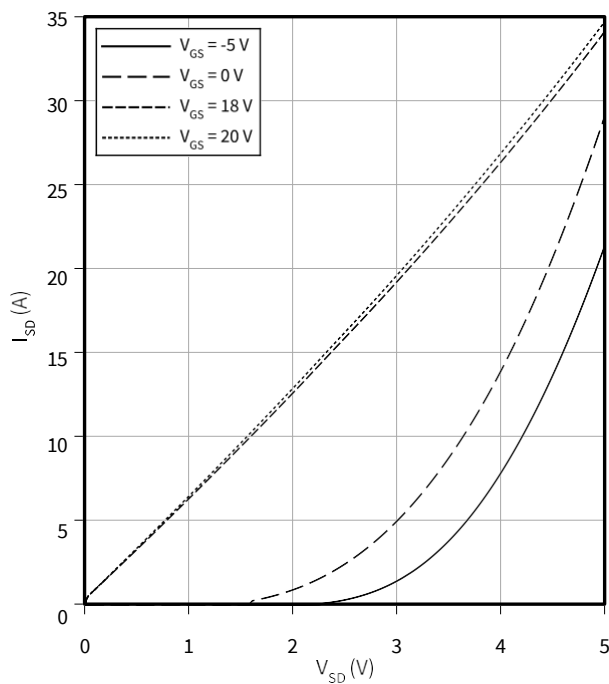
$$T_{vj} = 25 \text{ °C}, t_p = 20 \text{ } \mu\text{s}$$



**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$$I_{SD} = f(V_{SD})$$

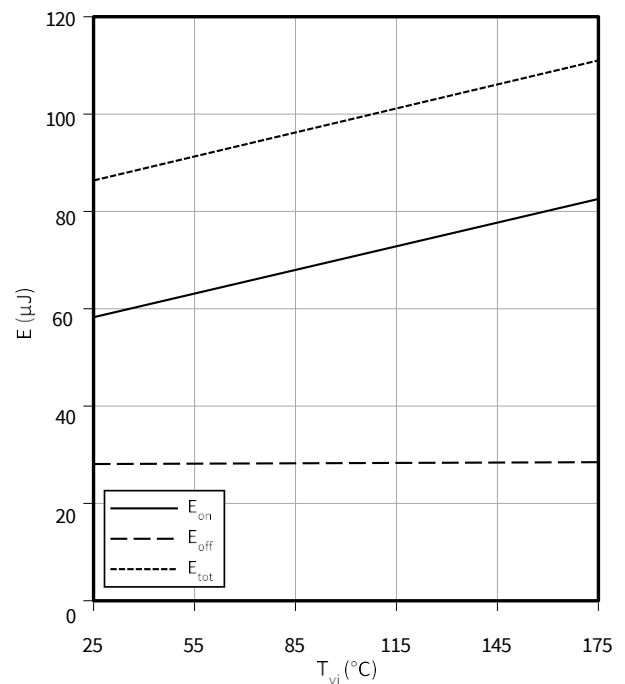
$$T_{vj} = 175 \text{ °C}, t_p = 20 \text{ } \mu\text{s}$$



**Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0 \text{ V}$**

$$E = f(T_{vj})$$

$$V_{GS} = 0/20 \text{ V}, I_D = 10 \text{ A}, R_{G,ext} = 2 \text{ } \Omega, V_{DD} = 800 \text{ V}$$

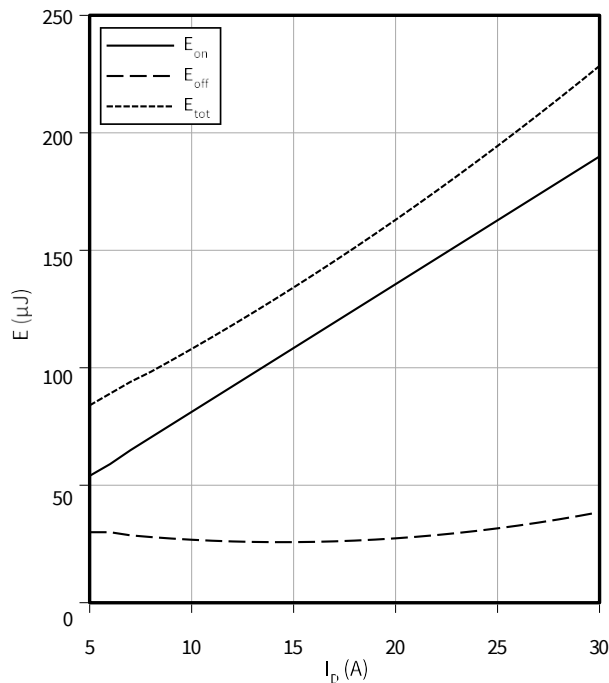


4 Characteristics diagrams

**Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$E = f(I_D)$$

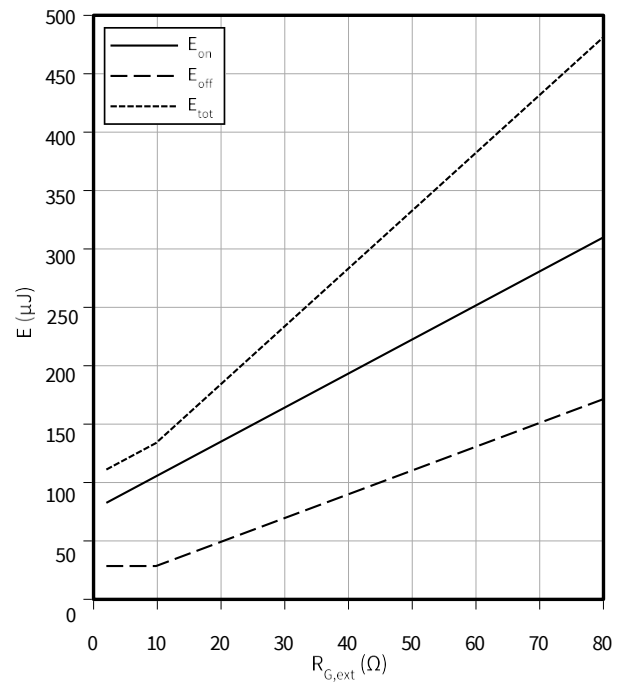
$V_{GS} = 0/20$  V,  $T_{vj} = 175$  °C,  $R_{G,ext} = 2$   $\Omega$ ,  $V_{DD} = 800$  V



**Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$E = f(R_{G,ext})$$

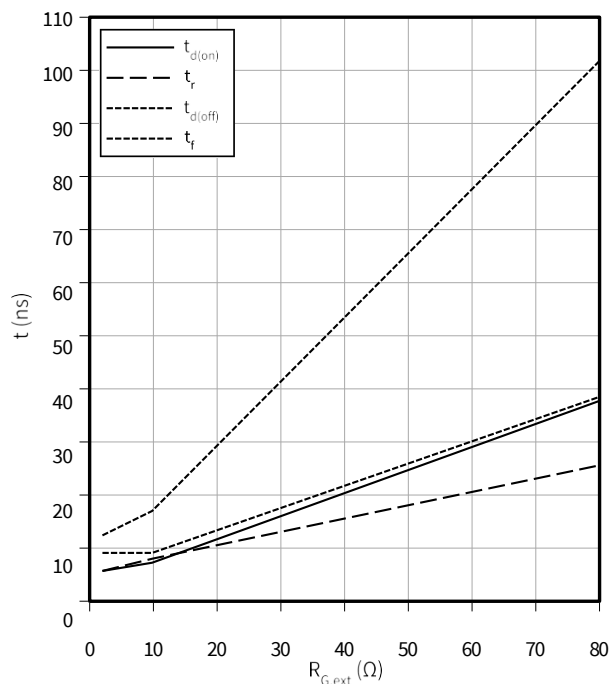
$V_{GS} = 0/20$  V,  $I_D = 10$  A,  $T_{vj} = 175$  °C,  $V_{DD} = 800$  V



**Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0$  V**

$$t = f(R_{G,ext})$$

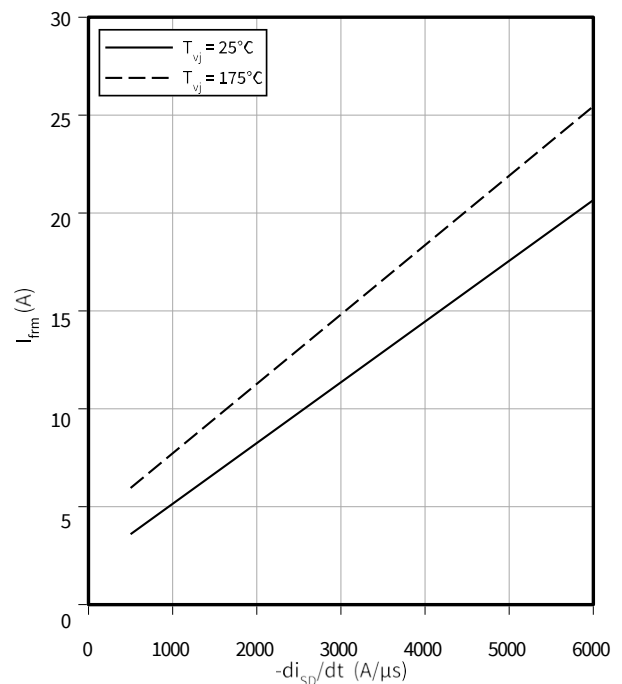
$V_{GS} = 0/20$  V,  $I_D = 10$  A,  $T_{vj} = 175$  °C,  $V_{DD} = 800$  V



**Typical MOSFET peak forward recovery current as a function of reverse drain current slope**

$$I_{frm} = f(-di_{SD}/dt)$$

$V_{GS} = 0/20$  V,  $I_{SD} = 10$  A,  $V_{DD} = 800$  V

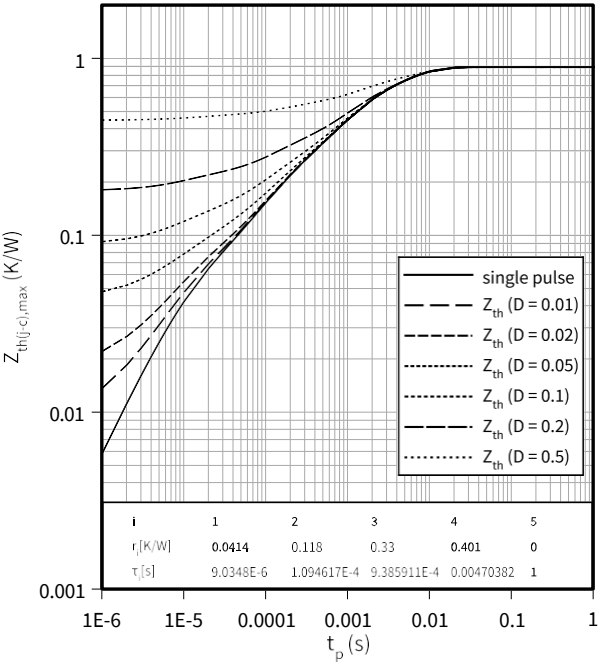


4 Characteristics diagrams

Max. transient thermal impedance (MOSFET/diode)

$Z_{th(j-c),max} = f(t_p)$

$D = t_p/T$



5 封装外形

5 封装外形

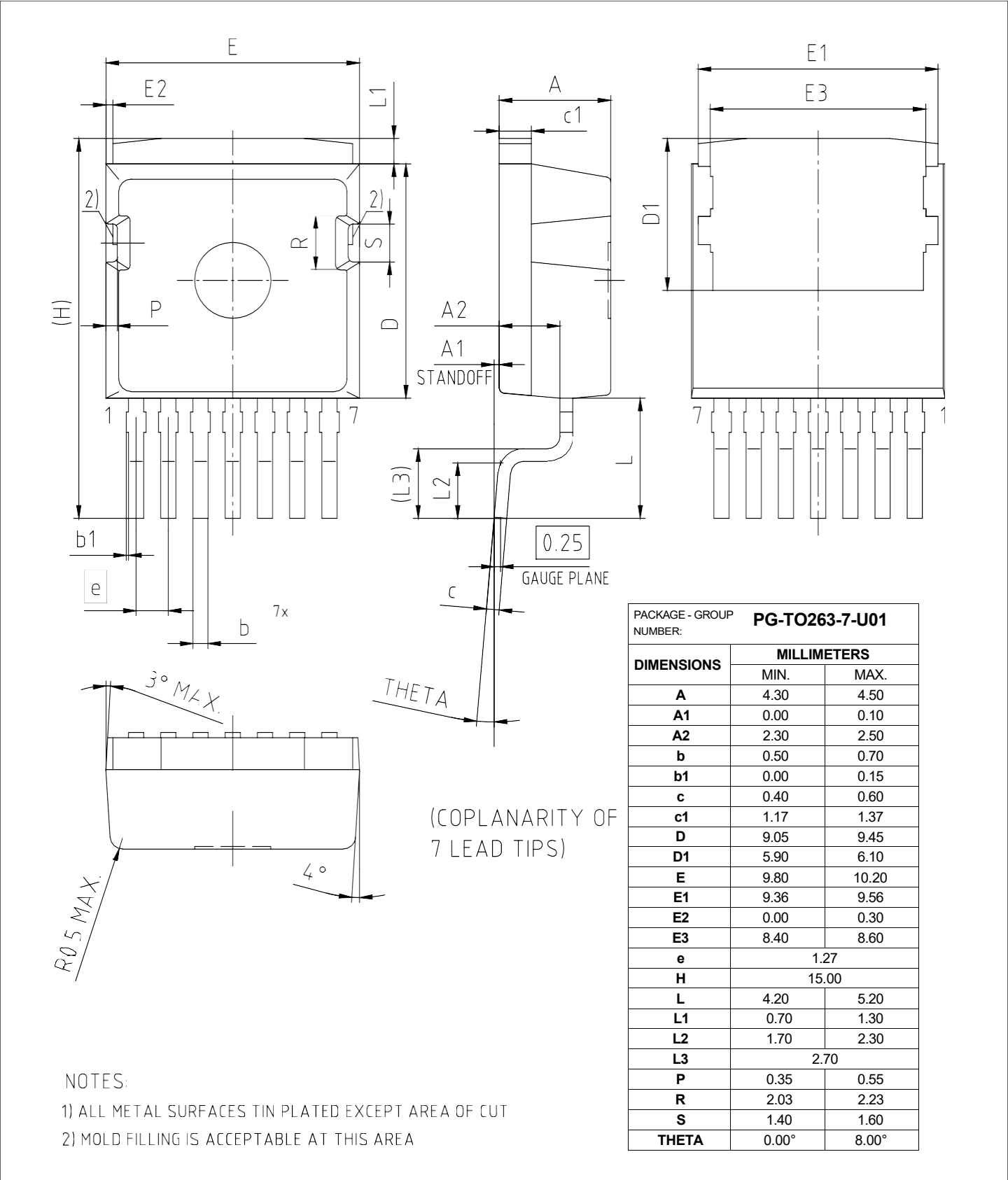


图 1

6 测试条件

6 测试条件

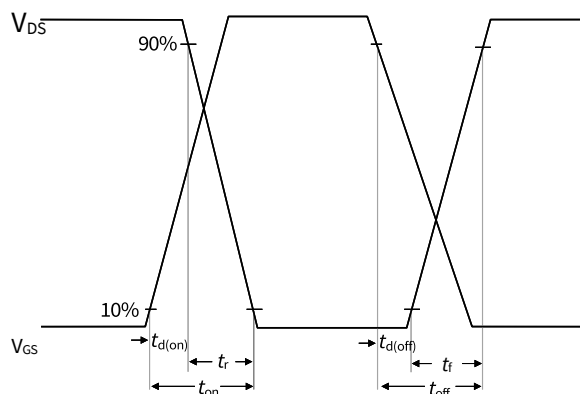
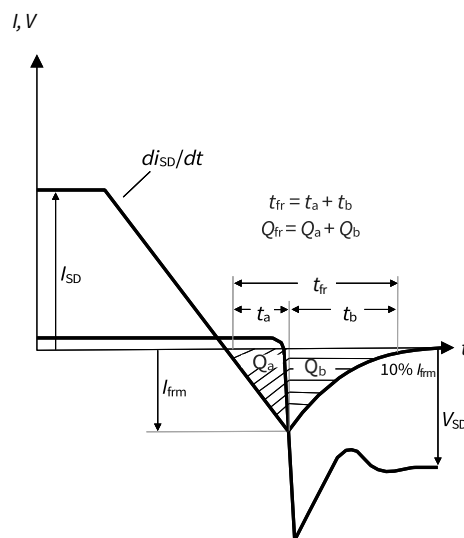


图 A.开关时间的定义



图B.体二极管开关特性的定义

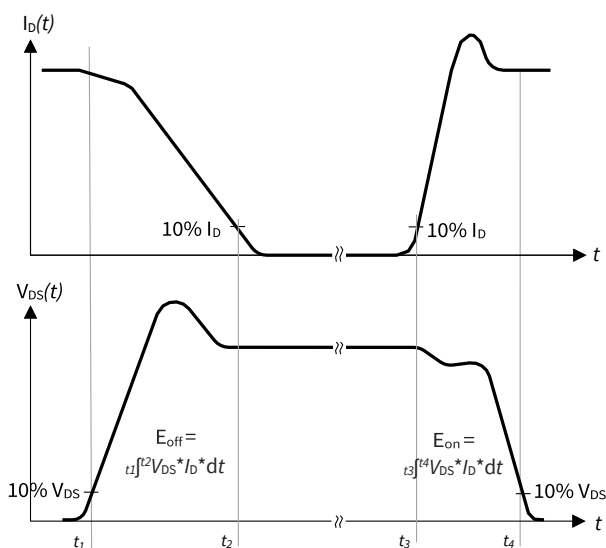


图 C.开关损耗的定义

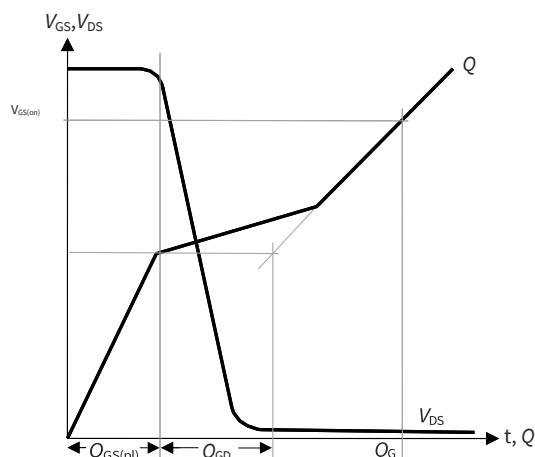


图 D. QGD 的定义

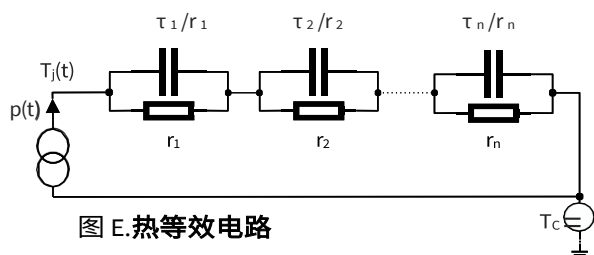
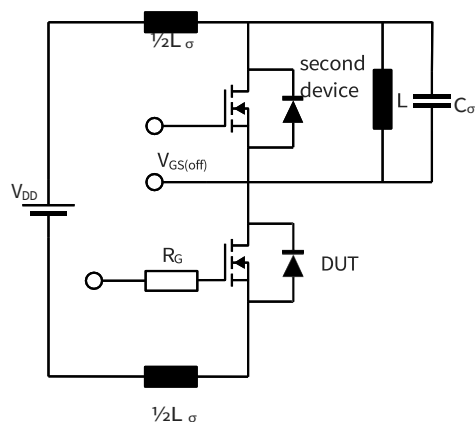


图 E.热等效电路



图F.动态测试电路

寄生电感 $L_\sigma$ ，寄生电容 $C_\sigma$



修订记录

修订记录

| Document revision | Date of release | Description of changes                                                                                                                                                                                                                                                                                                                                                                                         |
|-------------------|-----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0.10              | 2022-11-15      | Preliminary datasheet                                                                                                                                                                                                                                                                                                                                                                                          |
| 1.00              | 2023-04-25      | Final datasheet                                                                                                                                                                                                                                                                                                                                                                                                |
| 1.10              | 2024-04-02      | Updated table values: Idds, Rdson, Vgsth, Idss, gfs, Eoss, tdon, tr, tdoff, tf, Eon, Eoff, Etot,Qfr, Ifrm, Isdc, Ism<br>Updated graphs: IDS = f(VGS), VGS(th) = f(Tvj), IDS = f(VDS), RDS(on) = f(Tvj), ISD = f(VSD), E = f(Tvj), E = f(RG,ext), t = f(RG,ext), Ifrm = f(-diSD/dt )<br>Added new graphs: E = f(ID), Eoss = f(VDS)<br>No change to the product, new values based on additional characterization |
| 1.20              | 2024-11-12      | Updated features: “Minimal creepage distance 5.85mm (material group II) to fit 800V applications without coating” changed to “Creepage distance of 5.8mm (material group II) to fit 800V applications”<br>Updated package from PG-TO263-7-HV-ND5.8 to PG-TO263-7-U01                                                                                                                                           |



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